

<b>Notice of References Cited</b>	Application/Control No. 10/647,924		Applicant(s)/Patent Under Reexamination HARDMAN, CLAYTON M.	
	Examiner Emmanuel Bayard		Art Unit 2611	Page 1 of 1

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*	B	US-2003/0161295	08-2003	Shah et al.	370/352
*	C	US-2002/0100029	07-2002	Bowen, Matt	717/140
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